Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/537,668	SCHEFFEL ET AL.	
Examiner	Art Unit	
Hai H. Huynh	3747	

Hai H. Huynh

	SEARCHED				
Class	Subclass	Date	Examiner		
123	467-470	8/29/2007	ННН		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	8/29/2007	ннн		
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